## SPECIFICATIONS

Customer	
Product Name	Wire Wound SMD Power Inductor
Sunlord Part Number	SWPA4018S Series
Customer Part Number	

 $[\square New Released, \ \square Revised]$ 

SPEC No.: SWPA120000

[This SPEC is total 11 pages.] [ROHS Compliant Parts]

Approved By	Checked By	Issued By

### Shenzhen Sunlord Electronics Co., Ltd.

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<b>[For Customer appro</b> Qualification Status:	val Only ]	Restricted	Date: Rejected		
Approved By		Verified By	Re-checked By	Checked By	
Comments:					

#### [Version change history]

Rev.	Effective Date	Changed Contents	Change Reasons	Approved By
01	1	New released	/	Qintian Hou

#### Sunlord

#### Scope

This specification applies to the SWPA4018S Series of wire wound SMD power inductor.

#### 2 Product Description and Identification (Part Number)

1) Description:

SWPA4018S series of Wire wound SMD power inductor.

±20%

Tape Carrier Package

2) Product Identification (Part Number)



Туре				
014/DA	Wire wound SMD power			
SWPA	inductor			
	Feature type			
S	Standard Type			
Inductance Tolerance				
N	±30%			

Packing

4018	4.0X4.0X 1.8
<b></b>	
1	Nominal Inductance
Example	Example
1R0	1.0uH
100	10uH
101	100uH
·	
	Special Process code

\* Standard product is blank

External Dimensions(L×W×H) [mm]

Special Process code

I	Electrical	Cha	racteristics	;

#### Please refer to Item 12.

Μ

Т

3

- 1) Operating and storage temperature range (individual chip without packing): -40 ~ +125 (Including Self-heating)
- Storage temperature range (packaging conditions): -10 ~+40 and RH 70% (Max.) 2)

#### 4 **Test and Measurement Procedures**

#### 4.1 Test Conditions

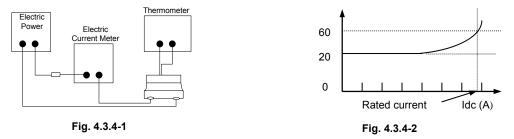
- 4.1.1 Unless otherwise specified, the standard atmospheric conditions for measurement/test as:
  - Ambient Temperature: 20±15 a.
  - Relative Humidity: 65±20% b.
  - Air Pressure: 86kPa to 106kPa C.
- 4.1.2 If any doubt on the results, measurements/tests should be made within the following limits:
  - Ambient Temperature: 20±2 a.
  - Relative Humidity: 65±5% b.
  - Air Pressure: 86kPa to 106kPa C.

#### 4.2 Visual Examination

Inspection Equipment: visual

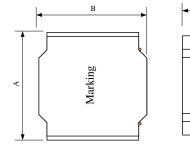
#### 4.3 Electrical Test

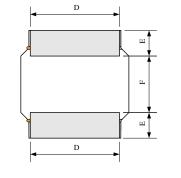
- 4.3.1 Inductance (L)
  - Refer to Item 12. Test equipment: WK3260B LCR meter or equivalent. a.
  - Test Frequency and Voltage: refers to Item 12. b.
- 4.3.2 Direct Current Resistance (DCR)
  - Refer to Item 12. a.
  - b. Test equipment: HIOKI 3540 or equivalent.
- 4.3.3 Saturation Current (Isat)
  - Refer to Item 12. a.
  - Test equipment: WK3260B LCR meter or equivalent. b.
  - Definition of saturation current (Isat): DC current at which the inductance drops approximate 30% from its value without c. current.
- 4.3.4 Temperature rise current (Irms)
  - Refer to Item 12. a.
  - b. Test equipment (see Fig. 4.3.4-1, Fig. 4.3.4-2): Electric Power, Electric current meter, Thermometer.
  - Measurement method C.
    - 1. Set test current to be 0 mA.
    - 2. Measure initial temperature of choke surface.
    - 3. Gradually increase current and measure choke temperature for corresponding current.
    - Definition of Temperature rise current: DC current that causes the temperature rise ( T =40°C) from 20°C ambient. 4.



#### 5 Shape and Dimensions

Dimensions and recommended PCB pattern for reflow soldering, please see Fig.5-1, Fig. 5-2 and Table 5-1.





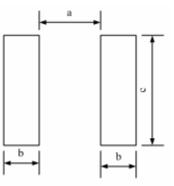
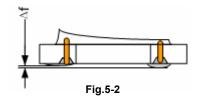


Fig.5-1

[Table 5-1] (Unit: mm)

Series	А	В	С	D	E	F	а	b	с
SWPA4018S	4.0±0.2	4.0±0.2	1.8 Max.	3.3±0.2	0.95±0.2	2.1±0.2	1.9 Тур.	1.1 Тур.	3.7 Тур.



Components

Ferrite Core

Magnetic Glue

**Plating Electrodes** 

Outer Electrodes

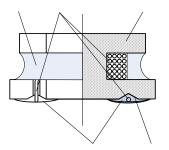
Wire

 $\Delta f$ : Clearance between terminal and the surface of plate must be 0.1mm max when coil is placed on a flat plate.

No.

#### 6 Structure

The structure of SWPA4018S product, please refer to Fig.6-1 and Table 6-1.





#### 7 Product Marking

Please refer to Fig. 7-1.

The content of marking please refers to Item 12.

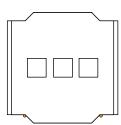


Fig. 7-1

#### [Table 6-1]

Ni-Zn Ferrite

Plating: Ag/Ni/ Sn

Material

Top surface solder coating:Sn96.5%/Ag3.0%/Cu0.5%

Polyurethane system enameled copper wire

Epoxy resin and magnetic powder

**Reliability Test** 

8

Items	Requirements	Test Methods and Remarks
8.1 Terminal Strength	No removal or split of the termination or other defects shall occur.	Solder the inductor to the testing jig (glass epoxy board shown in <b>Fig.8.1-1</b> ) using eutectic solder. Then apply a force in the direction of the arrow. 10N force. Keep time: 5s
8.2 Resistance to Flexure	Fig.8.1-1 No visible mechanical damage.	Solder the chip to the test jig (glass epoxy board) using eutectic solder. Then apply a force in the direction shown as <b>Fig.8.2-1</b> . Flexure: 2mm Pressurizing Speed: 0.5mm/sec Keep time: 30±1s Test board size: 100X40X1.0 Land dimension: Please see <b>Fig.5-1</b>
8.3 Vibration	No visible mechanical damage. Inductance change: Within ±10%	Solder the chip to the testing jig (glass epoxy board shown as the following figure) using eutectic solder. The chip shall be subjected to a simple harmonic motion having total amplitude of 1.5mm, the frequency being varied uniformly between the approximate limits of 10 and 55 Hz. The frequency range from 10 to 55 Hz and return to 10 Hz shall be traversed in approximately 1 minute. This motion shall be applied for a period of 2 hours in each 3 mutually perpendicular directions (total of 6 hours).
8.4 Temperature coefficient	Inductance change: Within ±20%	Temperature: -40 ~+125 With a reference value of +20 , change rate shall be calculated
8.5 Solderability	90% or more of electrode area shall be coated by new solder.	The test samples shall be dipped in flux, and then immersed in molten solder. Solder temperature: 245±5 Duration: 5±1 sec. Solder: Sn/3.0Ag/0.5Cu Flux: 25% resin and 75% ethanol in weight Immersion depth: all sides of mounting terminal shall be immersed
8.6 Resistance to Soldering Heat	No visible mechanical damage. Inductance change: Within ±10%	Re-flowing Profile: Please refer to Fig. 8.6-1. Test board thickness: 1.0mm Test board material: glass epoxy resin The chip shall be stabilized at normal condition for 1~2 hours before measuring 260 260 Max Ramp Up Rate=3 /sec. Max Ramp Down Rate=6 /sec 60 - 90sec. 25 Time 25 to Peak =8 min max Fig. 8.6-1

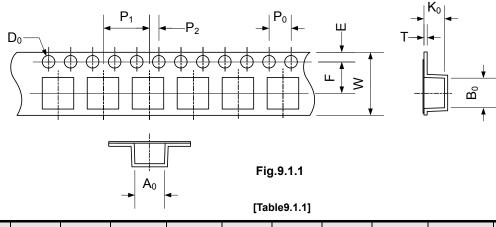
8.7 Thermal Shock	No visible mechanical damage. Inductance change: Within ±10% 125 30 min. 30 min. Ambient	Temperature and time: -40±3 for 30±3 min→125 for 30±3min, please refer to <b>Fig. 8.7-1</b> . Transforming interval: Max. 20 sec Tested cycle: 100 cycles The chip shall be stabilized at normal condition for 1~2 hours before measuring
8.8 Resistance to Low Temperature	No visible mechanical damage Inductance change: Within ±10%	Temperature: -40±3 Duration: 1000 <sup>±24</sup> hours The chip shall be stabilized at normal condition for 1~2 hours before measuring
8.9 Resistance to High Temperature	No mechanical damage. Inductance change: Within ±10%	Temperature: 125±2 Duration: 1000 <sup>±24</sup> hours The chip shall be stabilized at normal condition for 1~2 hours before measuring.
8.10 Damp Heat	No mechanical damage. Inductance change: Within ±10%	Temperature: 60±2 Humidity: 90% to 95%RH Duration: 1000 <sup>±24</sup> hours The chip shall be stabilized at normal condition for 1~2 hours before measuring
8.11 Loading Under Damp Heat	No mechanical damage. Inductance change: Within ±10%	Temperature: 60±2 Humidity: 90% to 95% RH Applied current: Rated current Duration:1000 <sup>±24</sup> hours The chip shall be stabilized at normal condition for 1~2 hours before measuring
8.12 Loading at High Temperature	No mechanical damage. Inductance change: Within ±10%	Temperature: 85±2 Applied current: Rated current Duration: 1000 <sup>±24</sup> hours The chip shall be stabilized at normal condition for 1~2 hours before measuring

#### 9 Packaging and Storage

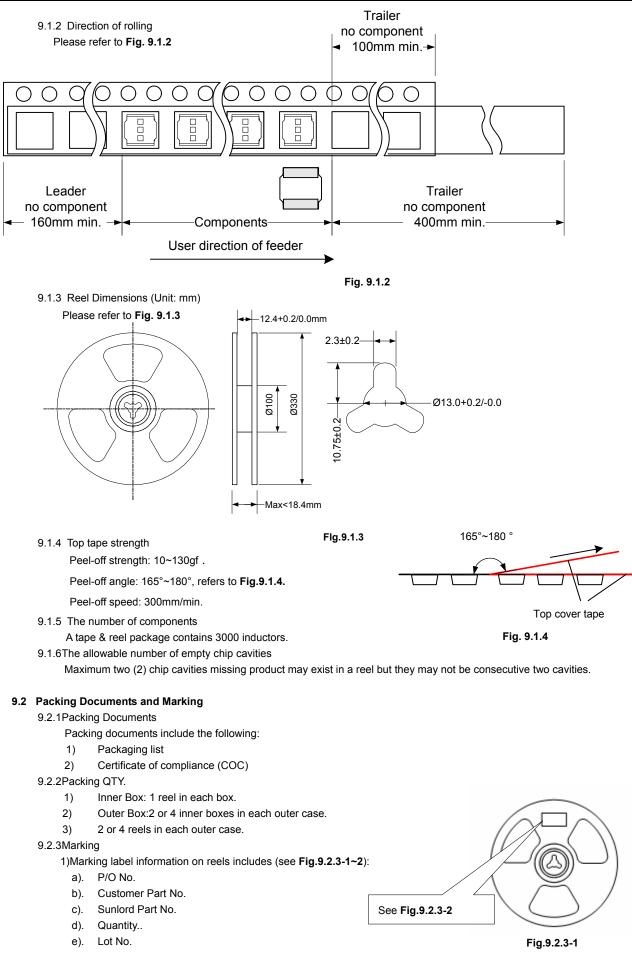
#### 9.1 Tape and Reel Packaging Dimensions

9.1.1Taping Dimensions (Unit: mm)

Please refer to Fig. 9.1.1 and Table 9.1.1.



Series	A <sub>0</sub>	B <sub>0</sub>	W	E	F	P <sub>0</sub>	P <sub>1</sub>	P <sub>2</sub>	D <sub>0</sub>	Т	K <sub>0</sub>
SWPA4018S	4.3±0.1	4.3±0.1	12.0±0.3	1.75±0.1	5.5±0.1	4.0±0.1	8.0±0.1	2.0±0.1	1.5+0./-0.1	0.35±0.03	2.1±0.1



f). Date code

- g). Inspection stamp
- h). MFG address as 'Made In China'

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#### Specifications for Wire Wound SMD Power Inductor

SHENZHEN SU	MADE IN CHINA		
Suniord	Datecod	e: XXXX	Hazardeus Substance Free
Lot NO.:	XXXXX		<b>HSF</b>
Quantity:	XXXX	PCS	
Sunlord Part N	<b>)</b> :: XXXXX	XXXXXXX	
Cust Part NO.:	XXXXXXX	00000	
P/O NO.	XXXXXX	00000	



2)Marking label information on inner box

- a). Inner box please refers to Fig.9.2.3-3and Table 9.2.3-1
- b). Marking Label on inner box
  - N/A

3)Marking on outer case (see Fig.9.2.3-4~6 ):

Out case size pleases reefers to Table 9.2.3-2.

- a). Manufacturer: Sunlord ID:
  - "Shenzhen Sunlord Electronics Co., Ltd." Packing label include the following:
    - i) Customer

b).

- ii) Manufacturer
- iii) Date code
- iv) C/No.

Example; "1/10" means that this case is the 1st one Of total 10 cases

- v) P/O No.
- vi) Customer Part No.
- vii) Sunlord Part No.
- viii) Quantity.
- ix) Inspection Stamp.

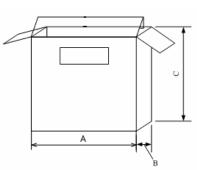


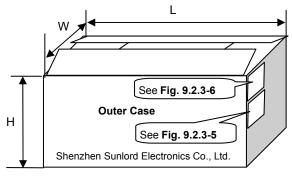
Fig.9.2.3-3

Packaging type	A(mm)	B(mm)	C(mm)
Inner box	340	30	340

[Table 9.2.3-1]

Packaging type	L(mm)	W(mm)	H(mm)
Type1	380	380	250
Туре2	380	380	190







SHENZHEN SUNLORD ELECTRONICS CO., LTD.		MADE IN CHIN
Sunlord	Data code: XXXXXXXX	HSF
Quantity: xxxx	XXXX	PASS
Sunlord Part No: )	xx-xx-xxxx	
Cust Part No: XXX	XXXXX	QA
P/O No: XXXXXX	xx	

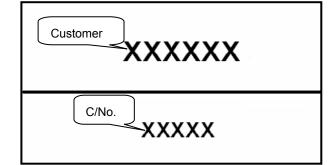


Fig.9.2.3-5



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Suniord         Specifications for Wire Wound SMD Power Inductor         Page 9 of 11           10         Visual inspection standard of product         Page 9 of 11							
File No:		Applied to	REV:01				
Effective date:		Applied to Wire Wound SMD Power Inductor Series					
No.	Defect Item	Graphic	Acceptance				
1	Core defect		The defect length/width (I or <i>w</i> ) more than L/6 or W/6, NG.	AQL=0.65			
2	Core crack		Visual cracks, NG.	AQL=0.65			
3	Starvation		Resin starved length, <i>I</i> , more than L/2, NG. IF <i>W</i> 2mm, resin starved width, <i>w</i> , more than W/2, NG. IF <i>W</i> 2mm, resin starved width, <i>w</i> , don't control.	AQL=0.65			
4	Excessive glue		The length, width or height of product beyond specified value, NG.	AQL=0.65			
5	Cold solder		For SWPA252012S, cold solders <i>I</i> more than 0.5 mm, NG. For other series, cold solders <i>I</i> more than 1 mm, NG.	AQL=0.65			
6	Solder icicle		The height <i>H</i> of product beyond specified value, NG; The clearance <i>Δf</i> beyond specified value listed in <b>Item 5</b> , NG;	AQL=0.65			
7	Electrode uneven	h	The clearance <b>Δf</b> beyond specified value listed in <b>Item 5</b> , NG;	AQL=0.65			
8	Marking defect		The content of marking 1) is indistinct, 2) disagrees with current product P/N requirements, NG; Intersection angle by L1 and L2 more than 45°, NG.	AQL=0.65			

#### Specifications for Wire Wound SMD Power Inductor

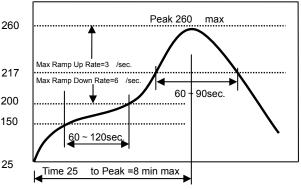
#### 11 Recommended Soldering Technologies

#### 11.1Re-flowing Profile:

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Preheat condition: 150 ~200 /60~120sec.	000
Allowed time above 217C: 60~90sec.	260
Max temp: 260	
Max time at max temp: 5sec.	047
Solder paste: Sn/3.0Ag/0.5Cu	217
Allowed Reflow time: 2x max	200
Please refer to Fig. 11.1-1.	
	150

[Note: The reflow profile in the above table is only for qualification and is not meant to specify board assembly profiles. Actual board assembly profiles must be based on the customer's specific board design, solder paste and process, and should not exceed the parameters as the Reflow profile shows.]

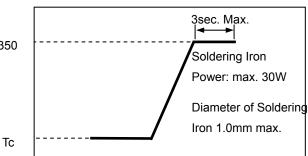




# **11.2 Iron Soldering Profile** Iron soldering power: Max. 30W Pre-heating: 150 /60sec. Soldering Tip temperature: 350 Max. Soldering time: 3sec. Max. Solder paste: Sn/3.0Ag/0.5Cu

Max.1 times for iron soldering Please refer to **Fig. 11.2-1**.

[Note: Take care not to apply the tip of the soldering iron to the terminal electrodes.]



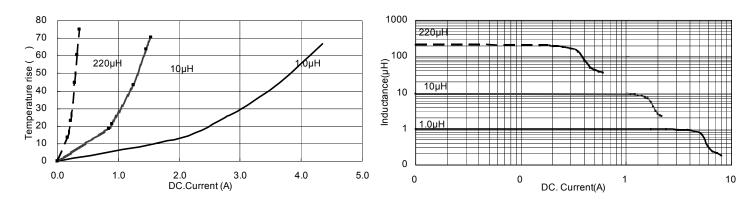


#### 12 Electrical Characteristics

Part Number	Inductance	L Tolerance	Inductance	DC	Max.	Max.	Min.
			Test	Resistance	Saturation	Temperature	Self-resonant
			Condition	(±30%)	Current	Rise Current	frequency
Units	μH	-	-	Ω	А	А	MHz
Symbol	L	-	-	DCR	lsat	Irms	SRF
SWPA4018S1R0NT	1.0	±30%	100KHz,1V	0.025	4.80	2.00	80
SWPA4018S1R5NT	1.5	±30%	100KHz,1V	0.030	3.35	1.80	65
SWPA4018S2R2MT	2.2	±20%	100KHz,1V	0.045	2.70	1.65	52
SWPA4018S3R3MT	3.3	±20%	100KHz,1V	0.070	2.45	1.23	44
SWPA4018S4R7MT	4.7	±20%	100KHz,1V	0.090	1.70	1.20	34
SWPA4018S6R8MT	6.8	±20%	100KHz,1V	0.110	1.45	1.06	29
SWPA4018S100MT	10	±20%	100KHz,1V	0.180	1.30	0.84	24
SWPA4018S150MT	15	±20%	100KHz,1V	0.250	0.94	0.65	19
SWPA4018S220MT	22	±20%	100KHz,1V	0.360	0.80	0.59	16
SWPA4018S330MT	33	±20%	100KHz,1V	0.530	0.56	0.49	12
SWPA4018S470MT	47	±20%	100KHz,1V	0.650	0.57	0.42	10
SWPA4018S680MT	68	±20%	100KHz,1V	1.000	0.47	0.32	8.3
SWPA4018S101MT	100	±20%	100KHz,1V	1.750	0.40	0.25	6.5
SWPA4018S151MT	150	±20%	100KHz,1V	2.500	0.31	0.22	5.5
SWPA4018S221MT	220	±20%	100KHz,1V	4.000	0.27	0.17	4.0

#### Typical Electrical Characteristics Temperature vs. DC Current Characteristics

Inductance vs. DC Current Characteristics



#### 13 Precautions

#### 13.1 Surface mounting

- Mounting and soldering condition should be checked beforehand.
- Applicable soldering process to this product is reflow soldering only.
- Recommended conditions for repair by soldering iron:
  - Preheat the circuit board with product to repair at 150 for about 1 minute.
  - Put soldering iron on the land-pattern.
  - Soldering iron's temperature: 350 maximum/Duration: 3 seconds maximum/1 time for each terminal.
  - The soldering iron should not directly touch the inductor.

Product once removes from the circuit board may not be used again.

#### 13.2 Handing

- Keep the products away from all magnets and magnetic objects.
- Be careful not to subject the products to excessive mechanical shocks.
- Please avoid applying impact to the products after mounted on pc board.
- Avoid ultrasonic cleaning.

#### 13.3 Storage

• To maintain the solderability of terminal electrodes and to keep the packing material in good condition, temperature and humidity in the storage area should be controlled.

- Recommended conditions: -10 ~40 , 70%RH (Max.)
- Even under ideal storage conditions, solderability of products electrodes may decrease as time passes. For this reason, product should be used with one year from the time of delivery.
- In case of storage over 6 months, solderability shall be checked before actual usage.

#### 13.4 Regarding Regulations

- Any Class- or Class- ozone-depleting substance (ODS) listed in the Clean Air Act in US for regulation is not included in the products or applied to the products at any stage of whose manufacturing processes.
- Certain brominated flame retardants (PBBs,PBDEs) are not used at all.
- The products of this specification are not subject to the Export Trade Control Order in China or the Export Administration Regulations in US.

#### 13.5 Guarantee

- The guaranteed operating conditions of the products are in accordance with the conditions specified in this specification.
- Please note that Sunlord takes no responsibility for any failure and/or abnormality which is caused by use under other than the aforesaid operating conditions.

#### 14 Supplier Information

#### 14.1 Supplier:

Shenzhen Sunlord Electronics Co., Ltd.

#### 14.2 Manufacturer:

Shenzhen Sunlord Electronics Co., Ltd.

#### 14.3 Manufacturing Address:

Sunlord Industrial Park, Dafuyuan Industrial Zone, Guanlan, Shenzhen, China Zip: 518110